MSKSEMI















ESD

TVS

TSS

MOV

GDT

PLED

Broduct data sheet



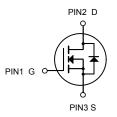












N-Channel MOSFET

TO-252

Description

The AOD480-MS uses advanced trench technology to provide excellent R_{DS(ON)}, low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

General Features

 $V_{DS} = 30V I_{D} = 20A$

 $R_{DS(ON)}$ < 25m Ω @ V_{GS} =10V

Application

Battery protection

Load switch

Uninterruptible power supply

Absolute Maximum Ratings (Tc=25°Cunless otherwise noted)

| Symbol | Parameter | Rating | Units |
|---------------------------------------|--|------------|-------|
| Vps | Drain-Source Voltage | 30 | V |
| Vgs | Gate-Source Voltage | ±20 | V |
| In@Tc=25°C | Continuous Drain Current, V _{GS} @ 10V ¹ | 20 | А |
| I _D @T _C =100°C | Continuous Drain Current, Ves @ 10V1 | 15 | А |
| In@Ta=25°C | Continuous Drain Current, Ves @ 10V1 | 7.3 | А |
| ID@TA=70°C | Continuous Drain Current, Ves @ 10V1 | 5.8 | А |
| Ідм | Pulsed Drain Current ² | 50 | А |
| EAS | Single Pulse Avalanche Energy ³ | 8.1 | mJ |
| las | Avalanche Current | 12.7 | А |
| P _D @T _C =25°C | Total Power Dissipation ⁴ | 20.8 | W |
| P _D @T _A =25°C | Total Power Dissipation ⁴ | 2 | W |
| Тѕтс | Storage Temperature Range | -55 to 150 | °C |
| TJ | Operating Junction Temperature Range | -55 to 150 | °C |
| R _θ JA | Thermal Resistance Junction-ambient ¹ | 62 | °C/W |
| Rejc | Thermal Resistance Junction-Case ¹ | 6 | °C/W |

Electrical Characteristics (T_C=25°C unless otherwise specified)

| Symbol | Parameter | Conditions | Min. | Тур. | Max. | Unit |
|------------------------|--|--|------|-------|------|-------|
| BVDSS | Drain-Source Breakdown Voltage | V _{GS} =0V , I _D =250uA | 30 | | | V |
| ∆BVpss/∆TJ | BVDSS Temperature Coefficient | Reference to 25°C , I _D =1mA | | 0.023 | | V/°C |
| | | V _{GS} =10V , I _D =10A | | 18 | 25 | |
| Rds(on) | Static Drain-Source On-Resistance ² | V _{GS} =4.5V , I _D =8A | | 25 | 38 | mΩ |
| V _{GS} (th) | Gate Threshold Voltage | | 1.0 | 1.2 | 2.5 | V |
| $\triangle V_{GS(th)}$ | V _{GS(th)} Temperature Coefficient | V _{GS} =V _{DS} , I _D =250uA | | -4.2 | | mV/°C |
| l | Drain-Source Leakage Current | V _{DS} =24V , V _{GS} =0V , T _J =25°C | | | 1 | |
| loss | | V _{DS} =24V , V _{GS} =0V , T _J =55°C | | | 5 | uA |
| Igss | Gate-Source Leakage Current | V _{GS} =±20V , V _{DS} =0V | | | ±100 | nA |
| gfs | Forward Transconductance | V _{DS} =5V , I _D =10A | | 5.5 | | S |
| Rg | Gate Resistance | V _{DS} =0V , V _{GS} =0V , f=1MHz | | 2.3 | | Ω |
| Qg | Total Gate Charge (4.5V) | | | 4.9 | | |
| Qgs | Gate-Source Charge | V _{DS} =15V , V _{GS} =4.5V , I _D =10A | | 1.66 | | nC |
| Qgd | Gate-Drain Charge | | | 1.85 | | |
| Td(on) | Turn-On Delay Time | | | 1.6 | | |
| Tr | Rise Time | V _{DD} =15V , V _{GS} =10V , | | 15.8 | | |
| T _d (off) | Turn-Off Delay Time | _R _G =3.3 _I _D =10A | | 13 | | ns |
| T _f | Fall Time | _ID-IUA | | 4.8 | | |
| Ciss | Input Capacitance | | | 416 | | |
| Coss | Output Capacitance | V _{DS} =15V , V _{GS} =0V , f=1MHz | | 62 | | pF |
| Crss | Reverse Transfer Capacitance | | | 51 | | |
| Is | Continuous Source Current ^{1,5} | | | | 24 | Α |
| Ism | Pulsed Source Current ^{2,5} | V _G =V _D =0V , Force Current | | | 50 | Α |
| Vsp | Diode Forward Voltage ² | V _{GS} =0V , I _S =1A , T _J =25°C | | | 1.2 | V |
| t _{rr} | Reverse Recovery Time | IF=10A , dI/dt=100A/μs , | | 8.7 | | nS |
| Qrr | Reverse Recovery Charge | T _J =25°C | | 1.95 | | nC |

Note:

- 1.The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
- 2The data tested by pulsed, pulse width. The EAS data shows Max. rating.
- 3he test condition is V $\! \leq \! 300 us$, duty cycle $_{DD=25} \! \leq \! V,\! V$ 2% $_{GS}$ =10V,L=0.1mH,I $_{AS}$ =12.7A
- 4.The power dissipation is limited by 150°C junction temperature
- 5.The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.





Typical Characteristics

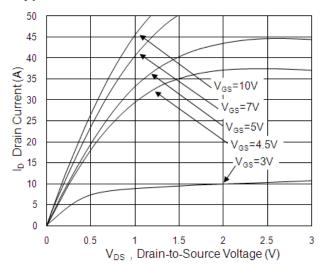


Fig.1 Typical Output Characteristics

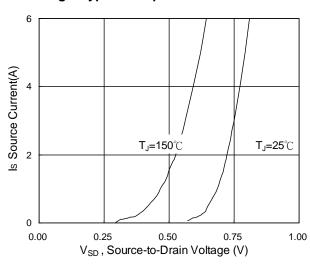


Fig.3 Forward Characteristics Of Reverse

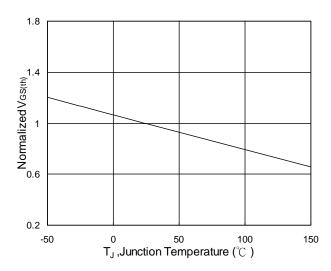


Fig.5 Normalized $V_{\text{GS(th)}}$ vs. T_{J}

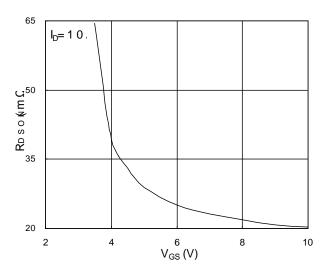


Fig.2 On-Resistance vs. Gate-Source

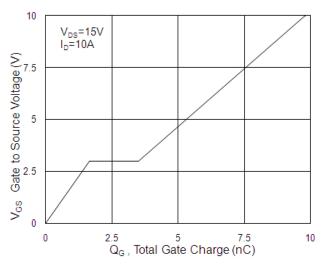


Fig.4 Gate-Charge Characteristics

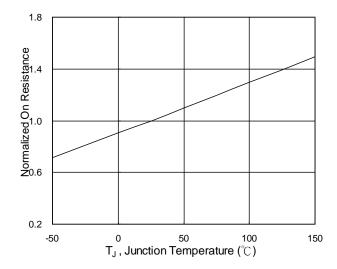
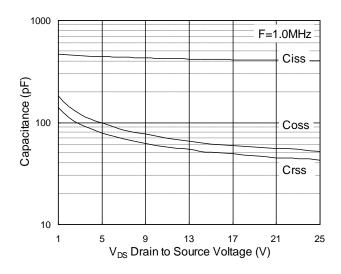


Fig.6 Normalized R_{DSON} vs. T_J



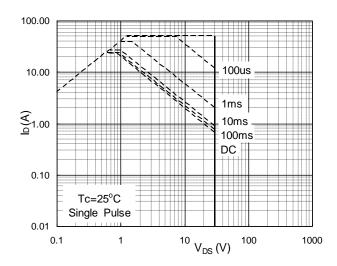


Fig.7 Capacitance

Fig.8 Safe Operating Area

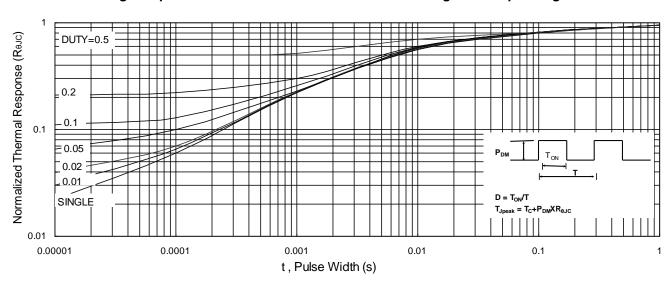


Fig.9 Normalized Maximum Transient Thermal Impedance

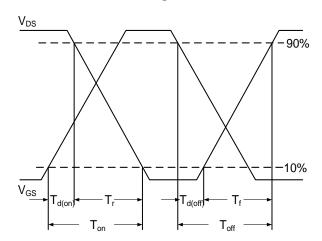


Fig.10 Switching Time Waveform

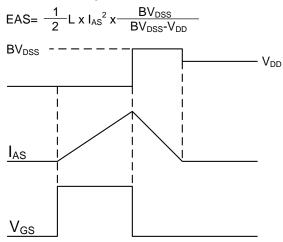


Fig.11 Unclamped Inductive Switching Waveform

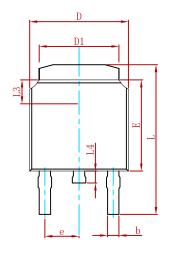


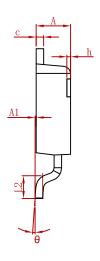


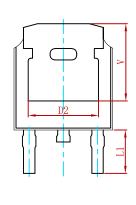




PACKAGE MECHANICAL DATA

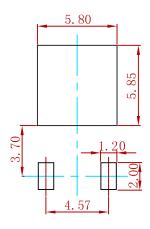






| 0 | Dimensions In Millimeters | | Dimensions In Inches | |
|--------|---------------------------|--------|----------------------|-------|
| Symbol | Min. | Max. | Min. | Max. |
| Α | 2.200 | 2.400 | 0.087 | 0.094 |
| A1 | 0.000 | 0.127 | 0.000 | 0.005 |
| b | 0.635 | 0.770 | 0.025 | 0.030 |
| С | 0.460 | 0.580 | 0.018 | 0.023 |
| D | 6.500 | 6.700 | 0.256 | 0.264 |
| D1 | 5.100 | 5.460 | 0.201 | 0.215 |
| D2 | 4.830 | REF. | 0.190 | REF. |
| Е | 6.000 | 6.200 | 0.236 | 0.244 |
| е | 2.186 | 2.386 | 0.086 | 0.094 |
| L | 9.712 | 10.312 | 0.382 | 0.406 |
| L1 | 2.900 | REF. | 0.114 | REF. |
| L2 | 1.400 | 1.700 | 0.055 | 0.067 |
| L3 | 1.600 REF. | | 0.063 | REF. |
| L4 | 0.600 | 1.000 | 0.024 | 0.039 |
| | | | | |
| θ | 0° | 8° | 0° | 8° |
| h | 0.000 | 0.300 | 0.000 | 0.012 |
| V | 5.250 | REF. | 0.207 | REF. |

Suggested Pad Layout



Note:

- 1.Controlling dimension:in millimeters.
- 2.General tolerance:± 0.05mm.
- 3. The pad layout is for reference purposes only.

REEL SPECIFICATION

| P/N | PKG | QTY |
|-----------|--------|------|
| AOD480-MS | TO-252 | 2500 |



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